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U.S. Patent Documents

Examiner Initials	Document No.	Date	Name	Class Subclass	Filing Date If Approp.
SH	5,048,933	9/91	Asano	349/61	
SH	5,691,782	11/97	Nishikawa et al	349/47	
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Foreign Patent Documents

Document No.	Date	Country	Class Subclass	Translation Yes No
SH 63-21907	5/88	Japan	X	ABS
SH 5-053121	3/93	Japan		
SH 5-173147	7/93	Japan		
SH 5-505247	8/93	Japan		
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SH	D. Klement et al., SID International Symposium, "Digest of Technical Papers", 1998, 26.2.
SH	Masahito Oh-e et al., Applied Physics Letters, "Electro-Optical Characteristics and Switching Behavior of the In-Plane Switching Mode", Vol. 67, pp. 3895-3897, 1995.
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SH	Tanaka et al., IDW '97 Proceedings of the Fourth International Display Workshops", November 19-21, 1997, Nagoya Congress Center, Nagoya, Japan.

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\*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609;  
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